



## N-Channel 12 V and 20 V (D-S) MOSFETs

PRODUCT SUMMARY				
	V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)
Channel 1	12	0.029 at V <sub>GS</sub> = 4.5 V	4.5 <sup>a</sup>	5.6 nC
		0.034 at V <sub>GS</sub> = 2.5 V	4.5 <sup>a</sup>	
		0.044 at V <sub>GS</sub> = 1.8 V	4.5 <sup>a</sup>	
		0.065 at V <sub>GS</sub> = 1.5 V	4.5 <sup>a</sup>	
Channel 2	20	0.225 at V <sub>GS</sub> = - 4.5 V	1.5 <sup>a</sup>	1.1 nC
		0.270 at V <sub>GS</sub> = - 2.5 V	1.5 <sup>a</sup>	
		0.345 at V <sub>GS</sub> = - 1.8 V	1.5 <sup>a</sup>	
		0.960 at V <sub>GS</sub> = - 1.5 V	0.5 <sup>a</sup>	

### FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFETs
- New Thermally Enhanced PowerPAK® SC-70 Package
  - Small Footprint Area
  - Low On-Resistance
- Typical ESD Performance for Channel 2: 2800 V
- Compliant to RoHS Directive 2002/95/EC

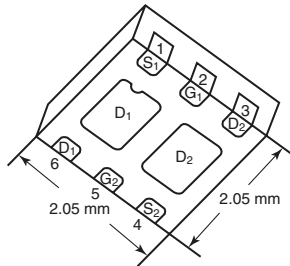


**RoHS**  
COMPLIANT  
HALOGEN  
**FREE**

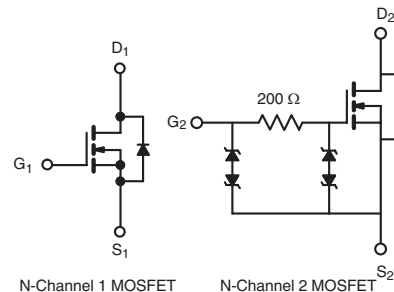
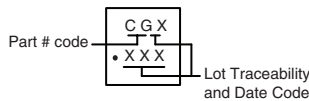
### APPLICATIONS

- N-Channel Level Shift Load Switch for Portable Devices
  - for 0 V to 8 V Power Lines

PowerPAK SC-70-6 Dual



Marking Code



Ordering Information: SiA778DJ-T1-GE3 (Lead (Pb)-free and Halogen-free)

N-Channel 1 MOSFET

N-Channel 2 MOSFET

ABSOLUTE MAXIMUM RATINGS T <sub>A</sub> = 25 °C, unless otherwise noted					
Parameter	Symbol	Channel 1	Channel 2	Unit	
Drain-Source Voltage	V <sub>DS</sub>	12	20	V	
Gate-Source Voltage	V <sub>GS</sub>	± 8	± 6		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	I <sub>D</sub>	T <sub>C</sub> = 25 °C	4.5 <sup>a</sup>	1.5 <sup>a</sup>	A
		T <sub>C</sub> = 70 °C	4.5 <sup>a</sup>	1.5 <sup>a</sup>	
		T <sub>A</sub> = 25 °C	4.5 <sup>a, b, c</sup>	1.5 <sup>b, c</sup>	
		T <sub>A</sub> = 70 °C	4.5 <sup>a, b, c</sup>	1.5 <sup>b, c</sup>	
Pulsed Drain Current	I <sub>DM</sub>	20	4		
Source Drain Current Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	4.5 <sup>a</sup>	1.5 <sup>a</sup>	
		T <sub>A</sub> = 25 °C	1.6 <sup>b, c</sup>	1.5 <sup>b, c</sup>	
Maximum Power Dissipation	P <sub>D</sub>	T <sub>C</sub> = 25 °C	6.5	5	W
		T <sub>C</sub> = 70 °C	5	3.2	
		T <sub>A</sub> = 25 °C	1.9 <sup>b, c</sup>	1.9 <sup>b, c</sup>	
		T <sub>A</sub> = 70 °C	1.2 <sup>b, c</sup>	1.2 <sup>b, c</sup>	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150		°C	
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>		260			

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Channel 1		Channel 2		Unit	
		Typ.	Max.	Typ.	Max.		
Maximum Junction-to-Ambient <sup>b, f</sup>	R <sub>thJA</sub>	52	65	52	65	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	12.5	16	20	25		

Notes:

a. Package limited.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. See solder profile ([www.vishay.com/ppg?73257](http://www.vishay.com/ppg?73257)). The PowerPAK SC-70 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under steady state conditions for channel 1 and channel 2 is 110 °C/W.

SPECIFICATIONS $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted							
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit	
<b>Static</b>							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	Ch-1	12			V
		$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	Ch-2	20			
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = 250\text{ }\mu\text{A}$	Ch-1		12		mV/ $^\circ\text{C}$
		$I_D = 250\text{ }\mu\text{A}$	Ch-2		21		
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250\text{ }\mu\text{A}$	Ch-1		-2.5		
		$I_D = 250\text{ }\mu\text{A}$	Ch-2		-2.3		
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	Ch-1	0.4		1	V
		$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	Ch-2	0.4		1	
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0\text{ V}, V_{GS} = \pm 8\text{ V}$	Ch-1			$\pm 100$	nA
		$V_{DS} = 0\text{ V}, V_{GS} = \pm 6\text{ V}$	Ch-2			1	mA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 12\text{ V}, V_{GS} = 0\text{ V}$	Ch-1			1	$\mu\text{A}$
		$V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}$	Ch-2			1	
		$V_{DS} = 12\text{ V}, V_{GS} = 0\text{ V}, T_J = 55\text{ }^\circ\text{C}$	Ch-1			10	
		$V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}, T_J = 55\text{ }^\circ\text{C}$	Ch-2			10	
On-State Drain Current <sup>b</sup>	$I_{D(on)}$	$V_{DS} \geq 5\text{ V}, V_{GS} = 4.5\text{ V}$	Ch-1	15			A
		$V_{DS} \geq 5\text{ V}, V_{GS} = 4.5\text{ V}$	Ch-2	4			
Drain-Source On-State Resistance <sup>b</sup>	$R_{DS(on)}$	$V_{GS} = 4.5\text{ V}, I_D = 5\text{ A}$	Ch-1		0.024	0.029	$\Omega$
		$V_{GS} = 4.5\text{ V}, I_D = 1.6\text{ A}$	Ch-2		0.183	0.225	
		$V_{GS} = 2.5\text{ V}, I_D = 4.6\text{ A}$	Ch-1		0.028	0.034	
		$V_{GS} = 2.5\text{ V}, I_D = 1.5\text{ A}$	Ch-2		0.220	0.270	
		$V_{GS} = 1.8\text{ V}, I_D = 4.1\text{ A}$	Ch-1		0.032	0.044	
		$V_{GS} = 1.8\text{ V}, I_D = 1.3\text{ A}$	Ch-2		0.275	0.345	
		$V_{GS} = 1.5\text{ V}, I_D = 2\text{ A}$	Ch-1		0.042	0.065	
		$V_{GS} = 1.5\text{ V}, I_D = 0.3\text{ A}$	Ch-2		0.320	0.960	
Forward Transconductance <sup>b</sup>	$g_{fs}$	$V_{DS} = 6\text{ V}, I_D = 5\text{ A}$	Ch-1		21		S
		$V_{DS} = 10\text{ V}, I_D = 1.6\text{ A}$	Ch-2		3.5		
<b>Dynamic<sup>a</sup></b>							
Input Capacitance	$C_{iss}$	Channel 1 $V_{DS} = 6\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	Ch-1		500		pF
Output Capacitance	$C_{oss}$		Ch-1		160		
Reverse Transfer Capacitance	$C_{rss}$		Ch-1		100		
Total Gate Charge	$Q_g$	$V_{DS} = 6\text{ V}, V_{GS} = 8\text{ V}, I_D = 6.5\text{ A}$	Ch-1		9.7	15	nC
		$V_{DS} = 10\text{ V}, V_{GS} = 5\text{ V}, I_D = 1.7\text{ A}$	Ch-2		1.3	2.2	
		Channel 1 $V_{DS} = 6\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 6.5\text{ A}$	Ch-1		5.6	8.5	
			Ch-2		1.1	1.7	
Gate-Source Charge	$Q_{gs}$	Channel 2 $V_{DS} = 10\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 1.7\text{ A}$	Ch-1		0.72		
			Ch-2		0.2		
Gate-Drain Charge	$Q_{gd}$	Channel 2 $V_{DS} = 10\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 1.7\text{ A}$	Ch-1		0.74		
			Ch-2		0.1		
Gate Resistance	$R_g$	$f = 1\text{ MHz}$	Ch-1	0.7	3.5	7	$\Omega$
			Ch-2	40	200	400	

Notes:

a. Guaranteed by design, not subject to production testing.

b. Pulse test; pulse width  $\leq 300\text{ }\mu\text{s}$ , duty cycle  $\leq 2\%$ .



SPECIFICATIONS $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted							
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit	
<b>Dynamic<sup>a</sup></b>							
Turn-On Delay Time	$t_{d(on)}$	Channel 1 $V_{DD} = 6\text{ V}$ , $R_L = 1.2\ \Omega$ $I_D \cong 5.2\text{ A}$ , $V_{GEN} = 4.5\text{ V}$ , $R_g = 1\ \Omega$	Ch-1		10	15	ns
			Ch-2		20	30	
Rise Time	$t_r$	Channel 2 $V_{DD} = 10\text{ V}$ , $R_L = 7.7\ \Omega$ $I_D \cong 1.3\text{ A}$ , $V_{GEN} = 4.5\text{ V}$ , $R_g = 1\ \Omega$	Ch-1		10	15	
			Ch-2		12	20	
Turn-Off Delay Time	$t_{d(off)}$		Ch-1		22	30	
			Ch-2		70	105	
Fall Time	$t_f$		Ch-1		10	15	
			Ch-2		20	30	
<b>Drain-Source Body Diode Characteristics</b>							
Continuous Source-Drain Diode Current	$I_S$	$T_C = 25\text{ }^\circ\text{C}$	Ch-1			4.5	A
			Ch-2			1.5	
Pulse Diode Forward Current <sup>a</sup>	$I_{SM}$		Ch-1			20	A
			Ch-2			4	
Body Diode Voltage	$V_{SD}$	$I_S = 5.2\text{ A}$ , $V_{GS} = 0\text{ V}$	Ch-1		0.85	1.2	V
		$I_S = 1.3\text{ A}$ , $V_{GS} = 0\text{ V}$	Ch-2		0.9	1.2	
Body Diode Reverse Recovery Time	$t_{rr}$	Channel 1 $I_F = 5.2\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ , $T_J = 25\text{ }^\circ\text{C}$	Ch-1		20	40	ns
			Ch-2		50	75	
Body Diode Reverse Recovery Charge	$Q_{rr}$	Channel 2 $I_F = 1.3\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ , $T_J = 25\text{ }^\circ\text{C}$	Ch-1		5	10	nC
			Ch-2		30	45	
Reverse Recovery Fall Time	$t_a$		Ch-1		8		ns
			Ch-2		115		
Reverse Recovery Rise Time	$t_b$		Ch-1		12		
			Ch-2		35		

Notes:

- a. Guaranteed by design, not subject to production testing.  
 b. Pulse test; pulse width  $\leq 300\ \mu\text{s}$ , duty cycle  $\leq 2\%$ .

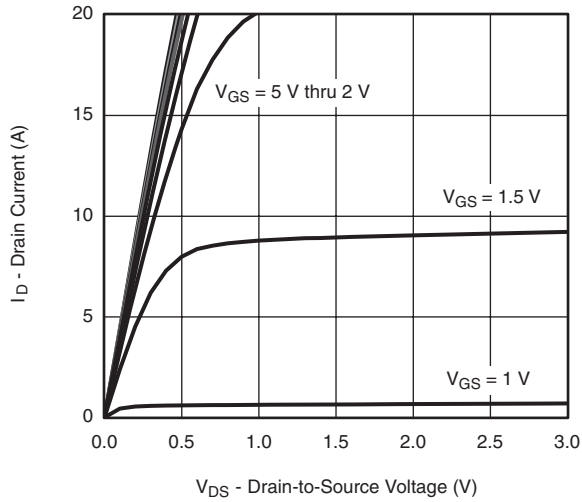
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

# SiA778DJ

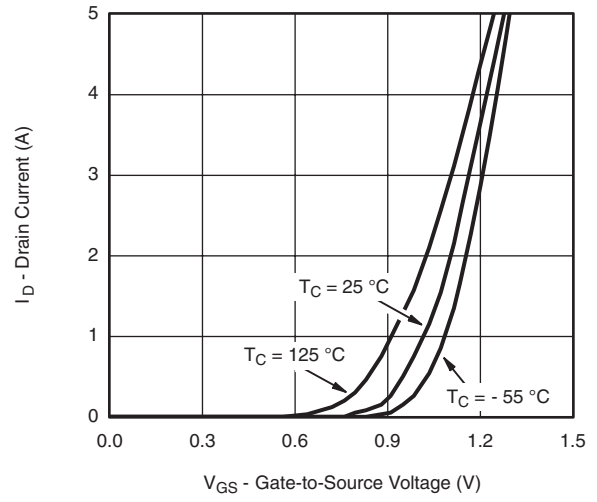
Vishay Siliconix



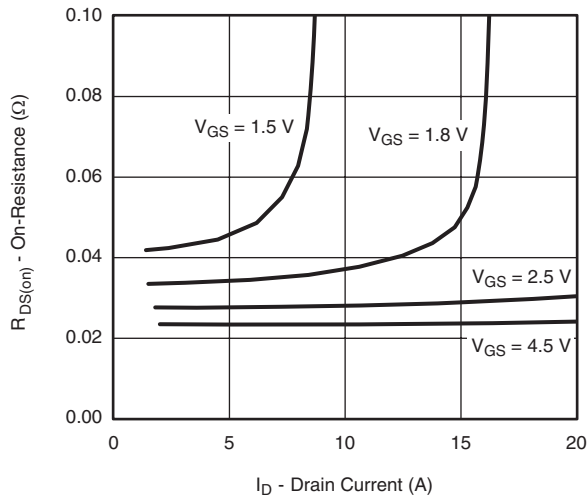
## CHANNEL 1 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



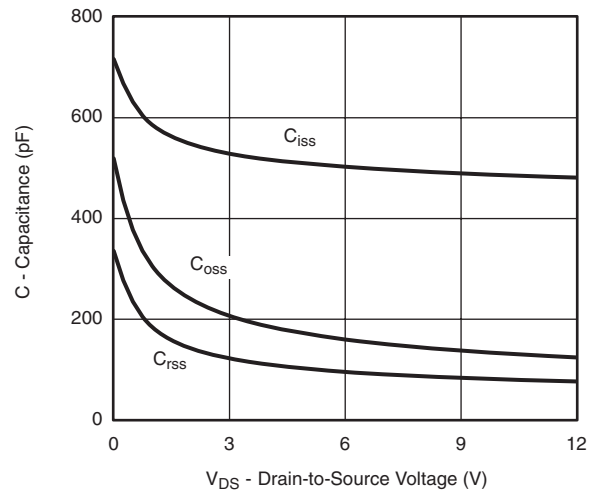
Output Characteristics



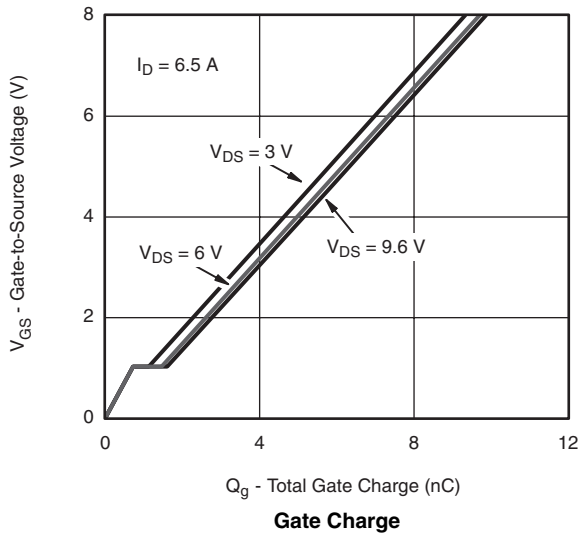
Transfer Characteristics



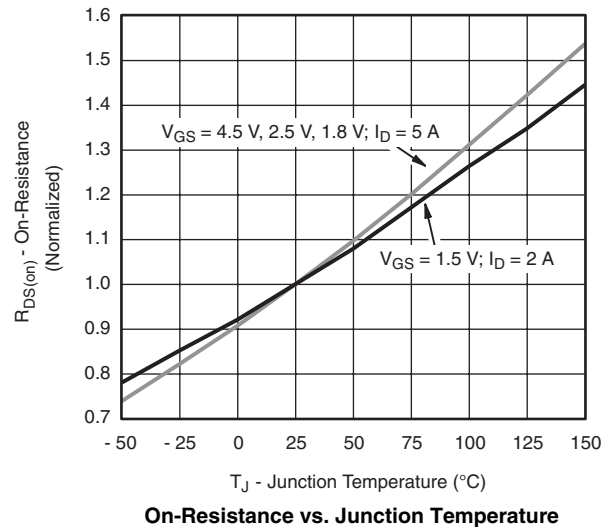
On-Resistance vs. Drain Current and Gate Voltage



Capacitance



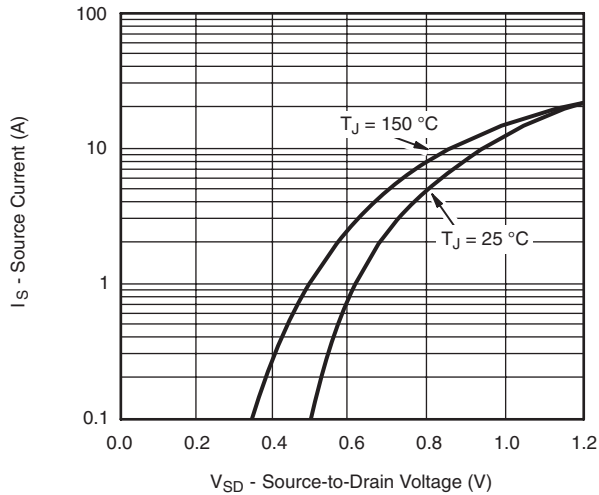
Gate Charge



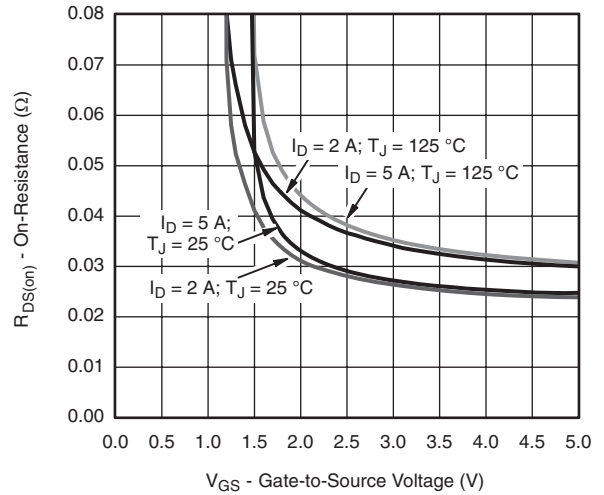
On-Resistance vs. Junction Temperature



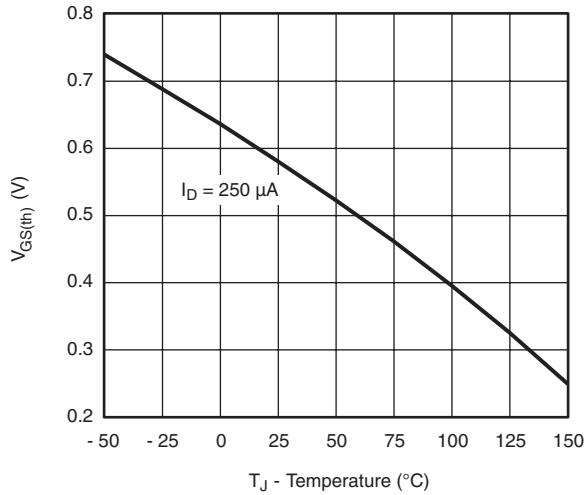
**CHANNEL 1 TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted



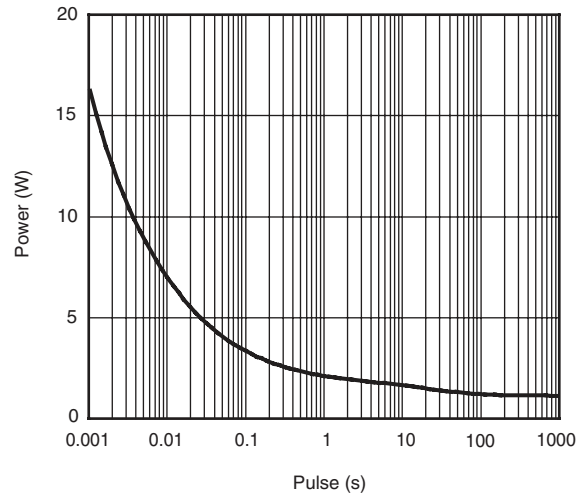
Source-Drain Diode Forward Voltage



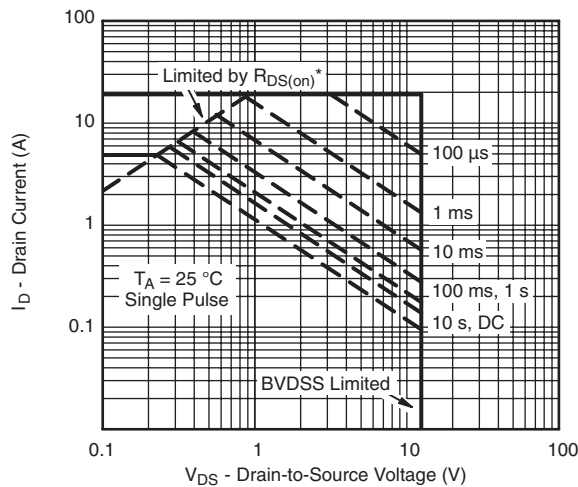
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power (Junction-to-Ambient)



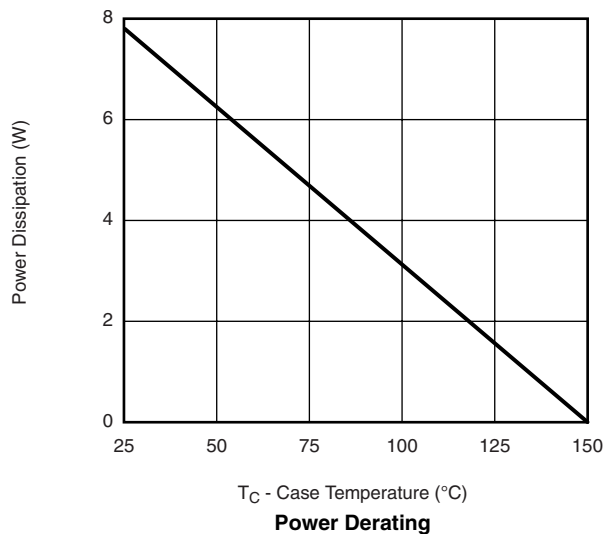
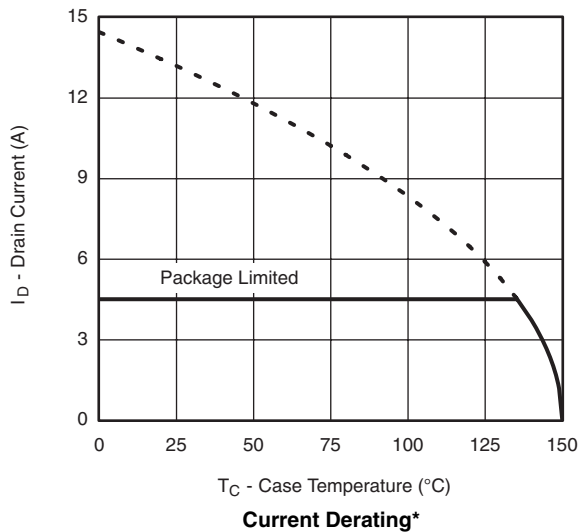
\*  $V_{GS} >$  minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified  
**Safe Operating Area, Junction-to-Ambient**

# SiA778DJ

Vishay Siliconix



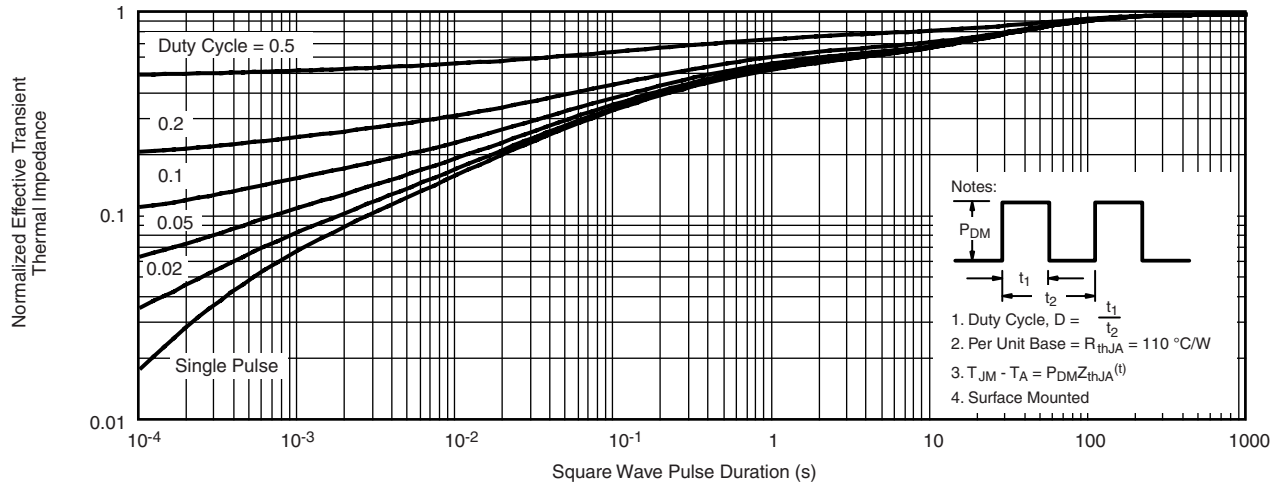
## CHANNEL 1 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



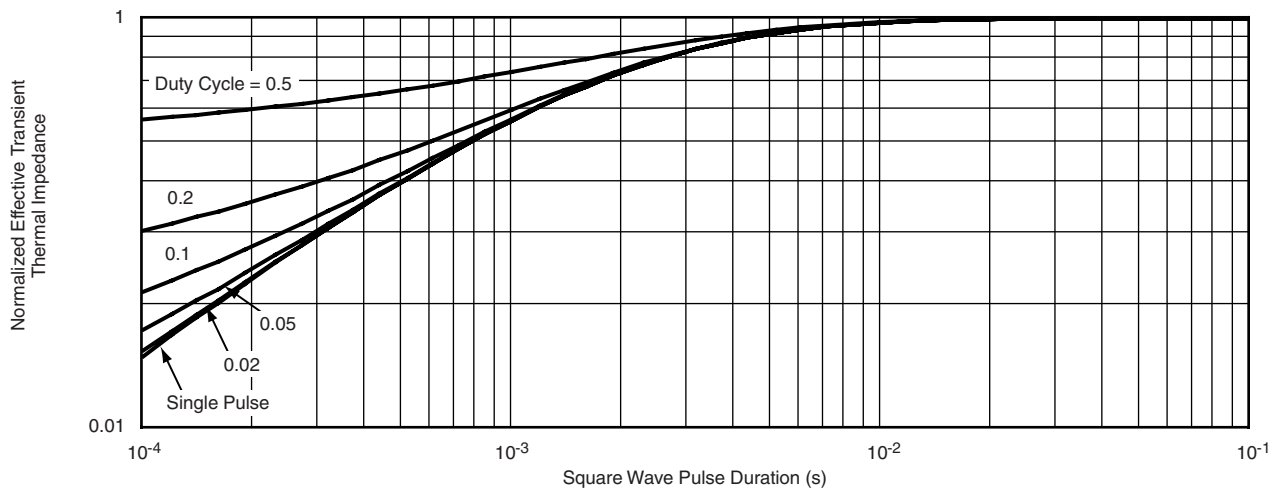
\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 150\text{ °C}$ , using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



**CHANNEL 1 TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

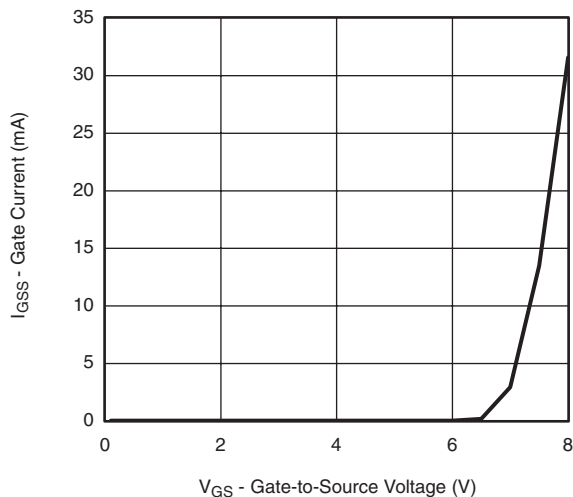


**Normalized Thermal Transient Impedance, Junction-to-Ambient**

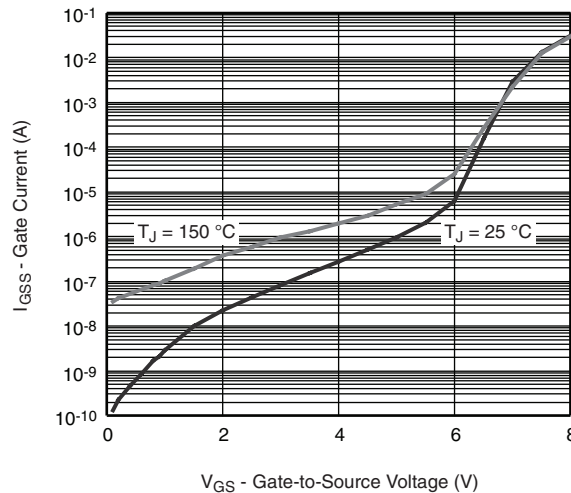


**Normalized Thermal Transient Impedance, Junction-to-Case**

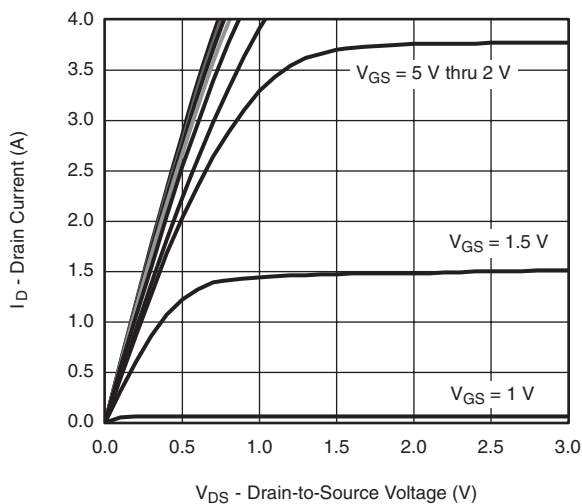
**CHANNEL 2 TYPICAL CHARACTERISTICS**  $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise noted



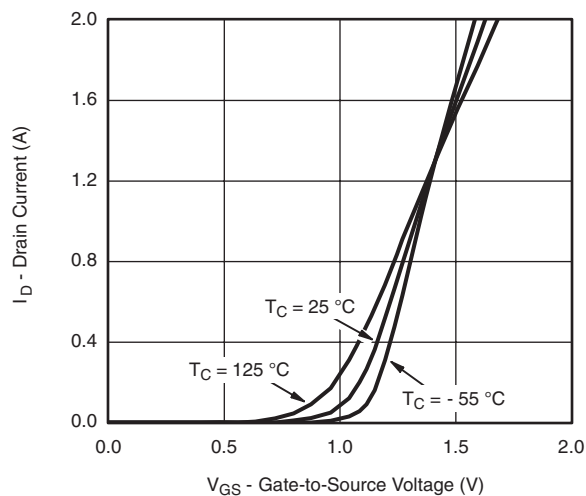
Gate Current vs. Gate-to-Source Voltage



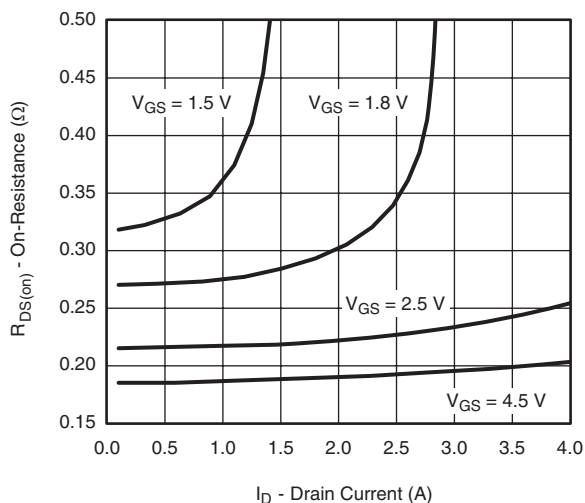
Gate Current vs. Gate-to-Source Voltage



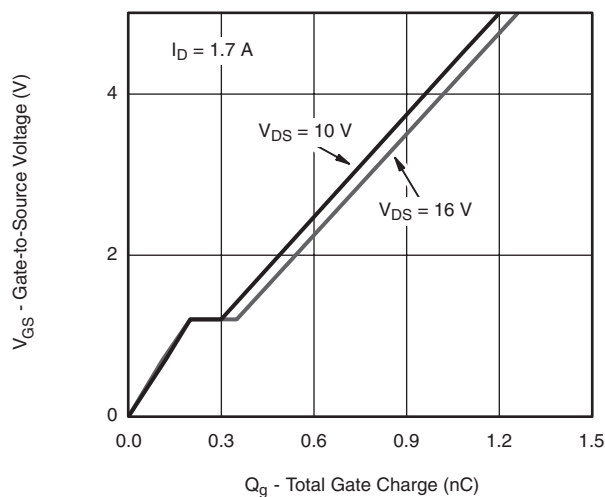
Output Characteristics



Transfer Characteristics



On-Resistance vs. Drain Current

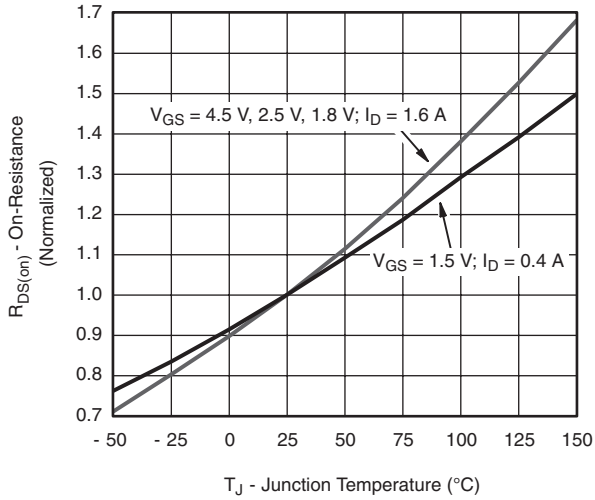


Gate Charge

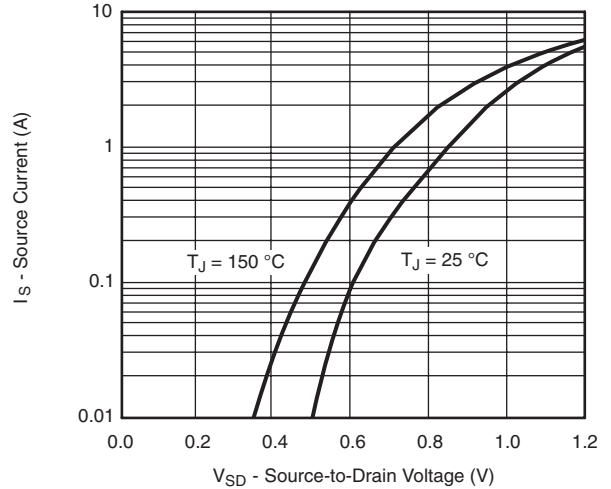




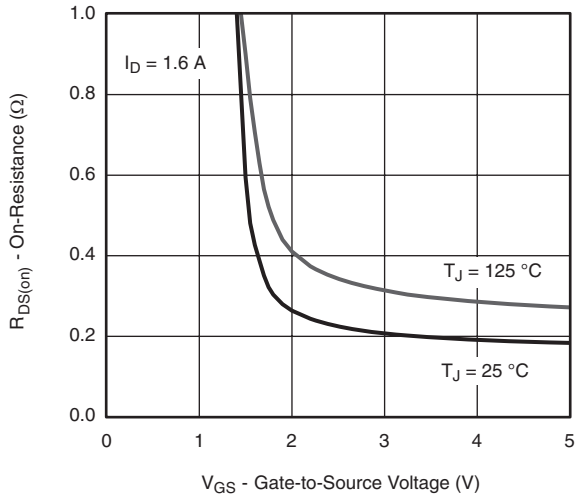
**CHANNEL 2 TYPICAL CHARACTERISTICS**  $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise noted



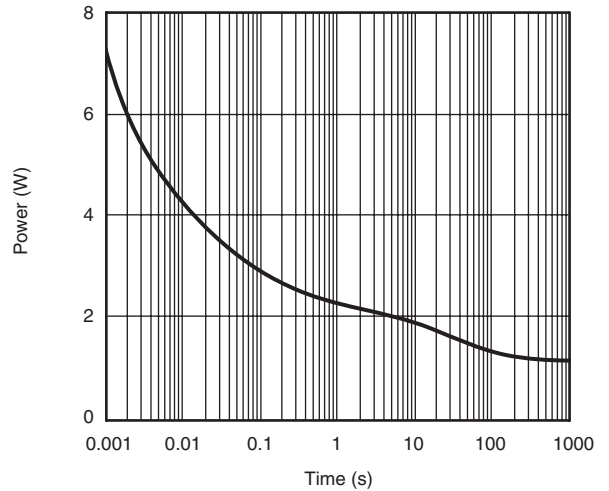
Normalized On-Resistance vs. Junction Temperature



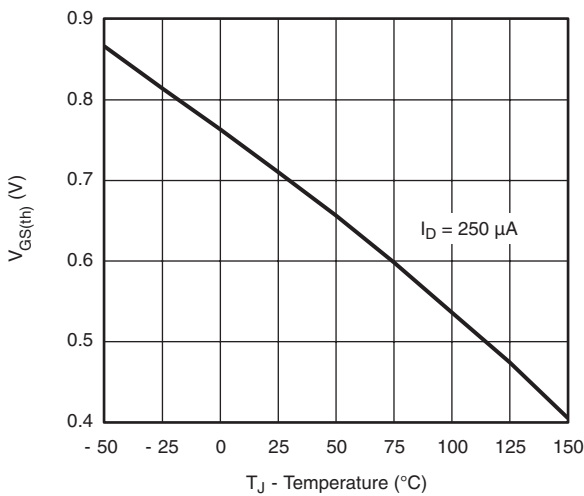
Source-Drain Diode Forward Voltage



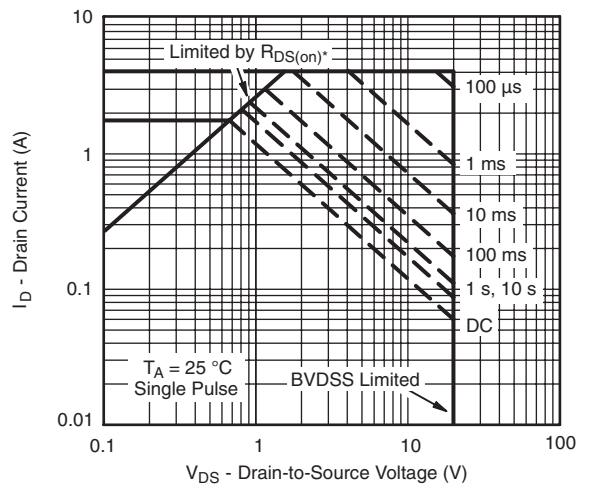
On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient



Threshold Voltage



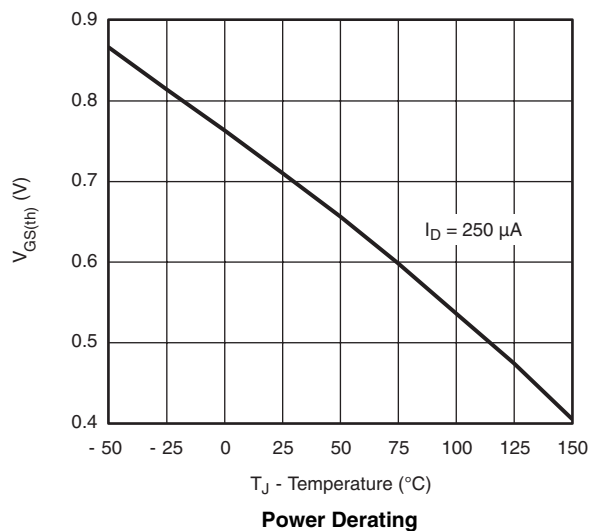
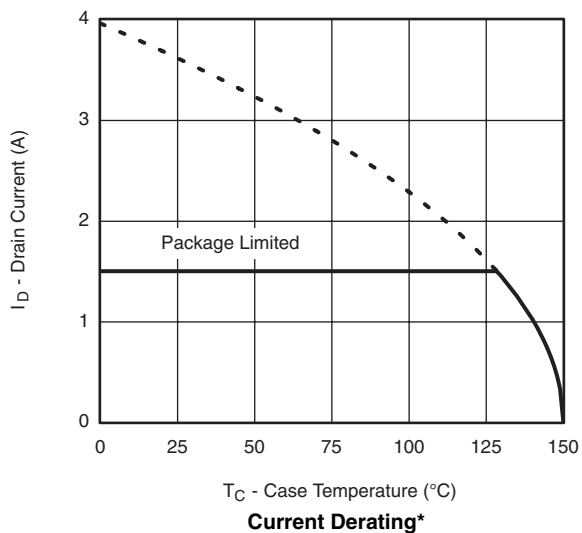
\*  $V_{GS} >$  minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified  
Safe Operating Area, Junction-to-Ambient

# SiA778DJ

Vishay Siliconix



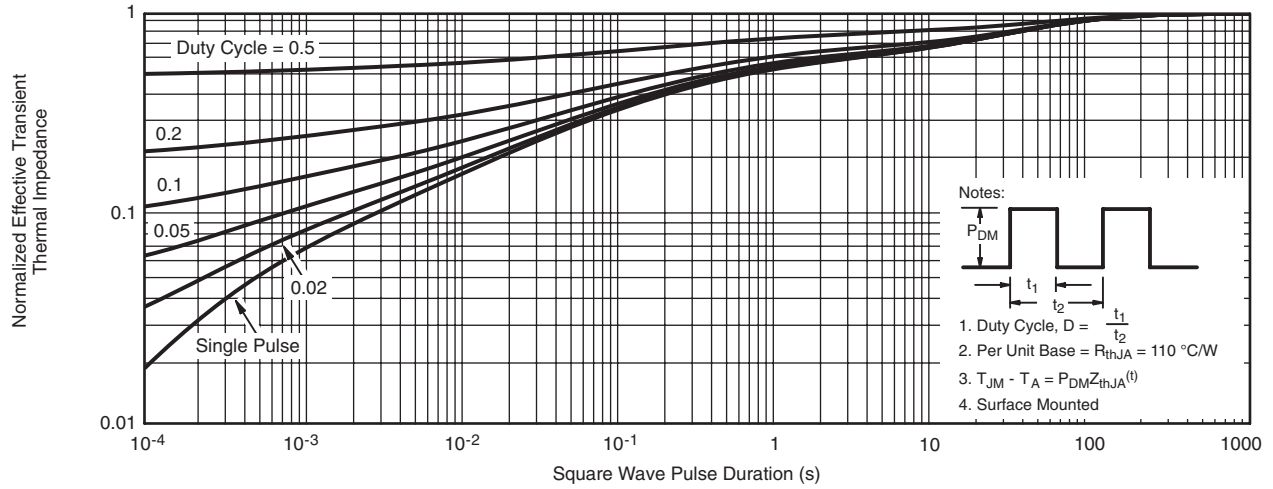
## CHANNEL 2 TYPICAL CHARACTERISTICS $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise noted



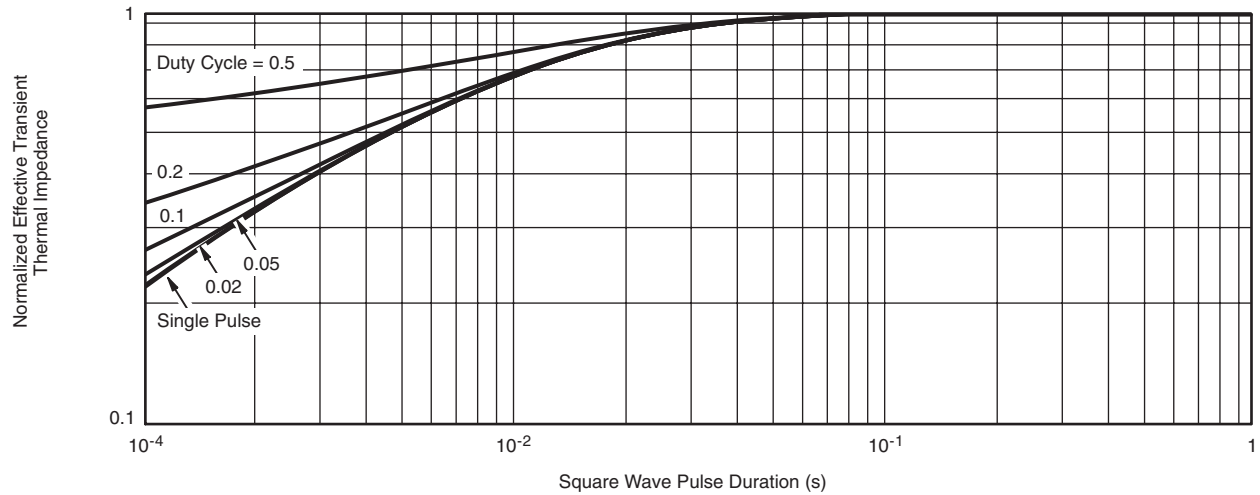
\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 150\text{ }^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



**CHANNEL 2 TYPICAL CHARACTERISTICS**  $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise noted



**Normalized Thermal Transient Impedance, Junction-to-Ambient**



**Normalized Thermal Transient Impedance, Junction-to-Case**

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see [www.vishay.com/ppg?65669](http://www.vishay.com/ppg?65669).



## Disclaimer

All product specifications and data are subject to change without notice.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained herein or in any other disclosure relating to any product.

Vishay disclaims any and all liability arising out of the use or application of any product described herein or of any information provided herein to the maximum extent permitted by law. The product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein, which apply to these products.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications unless otherwise expressly indicated. Customers using or selling Vishay products not expressly indicated for use in such applications do so entirely at their own risk and agree to fully indemnify Vishay for any damages arising or resulting from such use or sale. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

Product names and markings noted herein may be trademarks of their respective owners.

单击下面可查看定价，库存，交付和生命周期等信息

[>>Vishay\(威世\)](#)